

Notice of References Cited

Application/Control No.

10/553,416

Applicant(s)/Patent Under
Reexamination
OHMI ET AL.

Examiner

Thien F. Tran

Art Unit

2811

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,170,231	12-1992	Fujii et al.	257/177
*	B	US-6,677,648	01-2004	Ohmi, Tadahiro	257/374
	C	US-			
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	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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